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Front Matter: Volume 10116

, "Front Matter: Volume 10116," Proc. SPIE 10116, MOEMS and Miniaturized Systems XVI, 1011601 (31 May 2017); doi: 10.1117/12.2276167

SPIE.

Event: SPIE OPTO, 2017, San Francisco, California, United States

PROCEEDINGS OF SPIE

MOEMS and Miniaturized Systems XVI

Wibool Piyawattanametha
Yong-Hwa Park
Editors

30 January–1 February 2017
San Francisco, California, United States

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Published by
SPIE

Volume 10116

Proceedings of SPIE 0277-786X, V. 10116

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

MOEMS and Miniaturized Systems XVI, edited by Wibool Piyawattanametha,
Yong-Hwa Park, Proc. of SPIE Vol. 10116, 1011601 · © 2017 SPIE
CCC code: 0277-786X/17/\$18 · doi: 10.1117/12.2276167

Proc. of SPIE Vol. 10116 1011601-1

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Author(s), "Title of Paper," in *MOEMS and Miniaturized Systems XVI*, edited by Wibool Piyawattanametha, Yong-Hwa Park, Proceedings of SPIE Vol. 10116 (SPIE, Bellingham, WA, 2017) Seven-digit Article CID Number.

ISSN: 0277-786X

ISSN: 1996-756X (electronic)

ISBN: 9781510606739

ISBN: 9781510606746 (electronic)

Published by

SPIE

P.O. Box 10, Bellingham, Washington 98227-0010 USA

Telephone +1 360 676 3290 (Pacific Time) • Fax +1 360 647 1445

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Contents

v	<i>Authors</i>
vii	<i>Conference Committee</i>

MEMS SCANNERS AND MICROSCANNERS

10116 03	A contribution to the expansion of the applicability of electrostatic forces in micro transducers (Invited Paper) [10116-2]
10116 04	MEMS scanner with 2D tilt, piston, and focus motion [10116-3]
10116 05	Microcontroller based closed-loop control of a 2D quasi-static/resonant microscanner with on-chip piezo-resistive sensor feedback [10116-4]
10116 06	Reliability evaluation of a MEMS scanner [10116-5]
10116 07	Novel packaging approaches for increased robustness and overall performance of gimbal-less MEMS mirrors [10116-6]

MOEMS FOR OPTICAL ELEMENTS

10116 08	Scaling effect and its impact on wavelength-scale microlenses (Invited Paper) [10116-7]
10116 09	Low voltage electrowetting lenticular lens by using multilayer dielectric structure [10116-8]
10116 0A	Pitch variable liquid lens array using electrowetting [10116-9]
10116 0B	A fabrication method of opened structures for uniform liquid dosing in liquid lenticular systems [10116-10]
10116 0C	A miniaturized adaptive-focus camera objective employing a gravity-immune liquid-tunable aspherical lens (Best Student Paper Award) [10116-11]

MOEMS FOR COMPONENTS AND SYSTEMS I

10116 0E	A fast single-pixel laser imager for VR/AR headset tracking (Invited Paper) [10116-13]
10116 0G	Compact optical MEMS accelerometers and temperature sensors [10116-16]
10116 0H	Concept for the fast modulation of light in amplitude and phase using analog tilt-mirror arrays [10116-17]

MOEMS FOR COMPONENTS AND SYSTEMS II

- 10116 0I **VTT's Fabry-Perot interferometer technologies for hyperspectral imaging and mobile sensing applications (Invited Paper)** [10116-18]
- 10116 0J **A miniaturized near infrared spectrometer for non-invasive sensing of bio-markers as a wearable healthcare solution (Invited Paper, Best Paper Award)** [10116-19]
- 10116 0L **Environmental mid-infrared gas sensing using MEMS FTIR spectrometer** [10116-21]

CHARACTERIZATION OF MOEMS COMPONENTS AND SYSTEMS

- 10116 0M **MOEMS deformable mirror testing in cryo for future optical instrumentation (Invited Paper)** [10116-22]
- 10116 0N **Uncooled midwave infrared sensors for spaceborne assessment of fire characteristics** [10116-24]
- 10116 0P **Characteristics of amplitude modulation cantilever sensor with optical waveguide in liquid** [10116-26]
- 10116 0Q **Observation of thermal fluctuations in a superfluid optomechanical system** [10116-27]

Authors

Numbers in the index correspond to the last two digits of the seven-digit citation identifier (CID) article numbering system used in Proceedings of SPIE. The first five digits reflect the volume number. Base 36 numbering is employed for the last two digits and indicates the order of articles within the volume. Numbers start with 00, 01, 02, 03, 04, 05, 06, 07, 08, 09, 0A, 0B...0Z, followed by 10-1Z, 20-2Z, etc.

Aebi, Laurent, 0G	Langa, Sergiu, 03
Afanasyev, Sergey V., 0J	Lani, S., 04, 06
Akujärvi, Antti, 0I	Lanzoni, Patrick, 0M
Anikanov, Alexey G., 0J	Lee, Dong-ho, 0P
Ataman, Çağlar, 0C	Lee, Jin Su, 0A
Bae, Jungmok, 0J	Lee, Junsik, 09, 0B
Barette, Rudy, 0M	Lee, Kyung Woon, 0P
Barth, Robert, 05	Luetzelschwab, Markus, 0G
Bayat, Dara, 04, 0G	Mannila, Rami, 0I
Brown, C. D., 0Q	Marchis, Franck, 0M
Chae, Myung-Sic, 0P	Marozau, Y., 06
Châteauneuf, François, 0N	Medvedev, Anton S., 0J
Childress, L., 0Q	Milanović, Veljko, 07, 0E
Conrad, Holger, 03	Moon, Hyunseok, 0J
Dadras, M., 06	Morozov, Alexander V., 0J
Dreyhaupt, André, 05	Mortada, Bassem, 0L
Druzhin, Vladislav V., 0J	Näsilä, Antti, 0I
Dufour, Denis, 0N	Ngo Phong, Linh, 0N
Elsayed, Ahmed A., 0L	Ojanen, Harri, 0I
Erfan, Mazen, 0L	Onillon, E., 04
Flowers-Jacobs, N. E., 0Q	Ott, K., 0Q
Garcia, S., 0Q	Park, Jongae, 0J
Gaudet, Matthieu, 03	Park, Jung Ho, 0P
Généreux, Francis, 0N	Paultre, Jacques-Edmond, 0N
Grassi, Emmanuel, 0M	Petremand, Yves, 04, 0G
Grossmann, S., 04	Picard, Francis, 0N
Guo, Bin, 0I	Pierer, J., 04
Harris, J. G. E., 0Q	Regamey, Y.-J., 04
Heber, Jörg, 0H	Reichel, J., 0Q
Helmbrecht, Michael, 0M	Rissanen, Anna, 0I
Herzig, Hans Peter, 08	Roth, Matthias, 0H
Hoch, S. W., 0Q	Saari, Heikki, 0I
Hohmann, L., 0Q	Sabry, Yasser M., 0L
Hu, Frank, 07, 0E	Sandner, Thilo, 05
Hwang, Kyo Seon, 0P	Scharf, Toralf, 08
Jang, Hyeongseok, 0J	Schenk, Harald, 03
Janschek, Klaus, 05, 0H	Schimmanz, Klaus, 03
Kaiser, Bert, 03	Schroedter, Richard, 05
Kashkanova, A. D., 0Q	Schwarzenberg, Markus, 05
Kasturi, Abhishek, 07, 0E	Sharaf, Khaled, 0L
Khalil, Diaa, 0L	Shchekin, Alexey, 0J
Kim, Cheoljoong, 09, 0B	Shim, Jaewook, 0J
Kim, Dongho, 0J	Shin, Dooseub, 09, 0B
Kim, Jinsik, 0P	Shkarin, A. B., 0Q
Kim, Junoh, 09, 0A, 0B	Sim, Jee Hoon, 09, 0B
Kim, Myun-Sik, 08	Stolz, Michael, 03
Kim, Sang Kyu, 0J	Su, Yu Roger, 07
Kim, Yookwang, 0A	Teichman, Alex, 0M
Koo, Gyo Hyun, 09, 0B	Timotijevic, Branislav, 0G

Tormen, Maurizio, 0G
Uhlig, Sebastian, 03
Voelkel, Reinhard, 08
Vors, Patrick, 0M
Won, Yong Hyub, 09, 0A, 0B
Yang, James, 07, 0E
Zamkotsian, Frederic, 0M
Zappe, Hans, 0C
Zhao, Pengpeng, 0C

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- 1 MEMS-based Endoscopic Imaging: Joint Session with Conferences 10040 and 10116
Wibool Piyawattanametha, King Mongkut's Institute of Technology Ladkrabang (Thailand)
- 2 MEMS Scanners and Microscanners
Yong-Hwa Park, KAIST (Korea, Republic of)
- 3 MOEMS for Optical Elements
Jan Grahmann, Fraunhofer-Institut für Photonische Mikrosysteme (Germany)
- 4 MOEMS for Components and Systems I
David G. Lishan, Plasma-Therm LLC (United States)
- 5 MOEMS for Components and Systems II
Wyatt O. Davis, MicroVision, Inc. (United States)
- 6 Characterization of MOEMS Components and Systems
Ulrich Hofmann, Fraunhofer-Institut für Siliziumtechnologie (Germany)